

Search Notes

Application/Control No.

10/625,565

Examiner

Dieu-Minh Le

Applicant(s)/Patent under
Reexamination

KOISHI, TAKAHIRO

Art Unit

2114

SEARCHED

Class	Subclass	Date	Examiner
714	11	6/17/2006	DML
714	12	6/17/2006	DML
714	13	6/17/2006	DML

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
714	11	6/17/2006	DML
714	13	6/17/2006	DML

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search files US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM-TDB.	6/17/2006	DML
Inventor name search.	6/17/2006	DML
NPL database search [IEEE & ACM].	6/17/2006	DML
Interference text search - see search history printout.	6/17/2006	DML